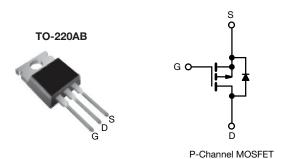




Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-100			
$R_{DS(on)}(\Omega)$	$V_{GS} = -10 \text{ V}$	0.30		
Q _g max. (nC)	38			
Q _{gs} (nC)	6.8			
Q _{gd} (nC)	21			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- 175 °C operating temperature
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9530PbF		
Lead (Pb)-free and halogen-free	IRF9530PbF-BE3		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage		V _{DS}	-100	V	
Gate-source voltage	V _{GS}	± 20			
Continuous drain current	$T_C = 25 ^{\circ}\text{C}$,	- 12	А	
	V_{GS} at 10 V $T_{C} = 100 ^{\circ}\text{C}$	I _D	-8.2		
Pulsed drain current ^a	I _{DM}	-48			
Linear derating factor		0.59	W/°C		
Single pulse avalanche energy b	E _{AS}	400	mJ		
Repetitive avalanche current ^a	I _{AR}	-12	Α		
Repetitive avalanche energy ^a		E _{AR}	8.8	mJ	
Maximum power dissipation	T _C = 25 °C	P _D	88	W	
Peak diode recovery dV/dt ^c		dV/dt	- 5.5	V/ns	
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +175	°C		
Soldering recommendations (peak temperature) ^d	For 10 s		300		
Mounting torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-3∠ or ivi3 screw		1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = -25 V, starting T_J = 25 °C, L = 4.2 mH, R_q = 25 Ω , I_{AS} = -12 A (see fig. 12)
- c. $I_{SD} \le -12$ A, $dI/dt \le 140$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	=	62	
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	1.7	

SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$, UPARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static	01111202					111111111	<u> </u>
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = -250 μA		-100	_	T -	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		Reference to 25 °C, $I_D = -2.50 \mu A$		-0.10	_	V/°C
Gate-source threshold voltage	V _{GS(th)}		V _{DS} = V _{GS} , I _D = -250 µA		-	-4.0	V
Gate-source leakage	I _{GSS}	50	$V_{DS} = V_{GS}, ID = -230 \mu\text{A}$ $V_{GS} = \pm 20 \text{V}$		-	± 100	nA
auto oouroo rouriago	1922	$V_{GS} = \pm 20 \text{ V}$ $V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}$		-	_	-100	μА
Zero gate voltage drain current	I _{DSS}		$V_{DS} = -100 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 \text{ °C}$		_	-500	
Drain-source on-state resistance	R _{DS(on)}		I _D = -7.2 A b	-	-	0.30	Ω
Forward transconductance	9fs	V _{DS} = -50 V, I _D = -7.2 A ^b		3.7	-	-	S
Dynamic					l		l
Input capacitance	C _{iss}	V 0V		-	860	-	
Output capacitance	C _{oss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$		340	-	pF
Reverse transfer capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	93	-	† ' '
Total gate charge	Qq			-	-	38	nC
Gate-source charge	Q _{gs}	V _{GS} = -10 V	I _D = -12 A, V _{DS} = -80 V, see fig. 6 and 13 ^b	-		6.8	
Gate-drain charge	Q _{gd}	1	See lig. o and 13 5	-	-	21	
Turn-on delay time	t _{d(on)}			-	12	-	
Rise time	t _r	Vpp = -	V _{DD} = -50 V, I _D = -12 A,		52	-	- ns
Turn-off delay time	t _{d(off)}	$R_{\rm g}$ = 12 Ω , $R_{\rm D}$ = 3.9 Ω , see fig. 10 ^b		-	31	-	
Fall time	t _f			-	39	-	
Gate input resistance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal drain inductance	L _S			-	7.5	-	
Internal source inductance	R _g	f = 1 MHz, open drain		0.4	-	3.3	Ω
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p -n junction diode		-	-	-12	A
Pulsed diode forward current ^a	I _{SM}			-	-	-48	
Body diode voltage	V _{SD}	T_J = 25 °C, I_S = -12 A, V_{GS} = 0 V b		_	-	-6.3	V
Body diode reverse recovery time	t _{rr}	$T_{\rm J} = 25~{\rm ^{\circ}C}, I_{\rm F} = -12~{\rm A}, dI/dt = 100~{\rm A/\mu s}^{\rm b}$		_	120	240	ns
Body diode reverse recovery charge	Q _{rr}			-	0.46	0.92	μC
Forward turn-on time	t _{on}	Intrinsic turr	n-on is dominated by L _S and L _D)				

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

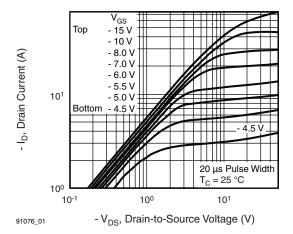


Fig. 1 -Typical Output Characteristics, T_C = 25 °C

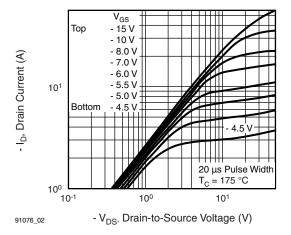


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

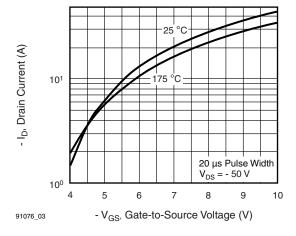


Fig. 3 - Typical Transfer Characteristics

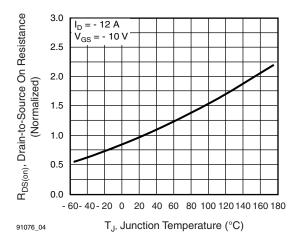


Fig. 4 - Normalized On-Resistance vs. Temperature

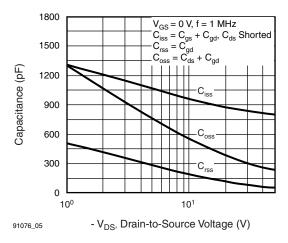


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

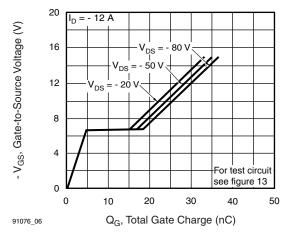


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



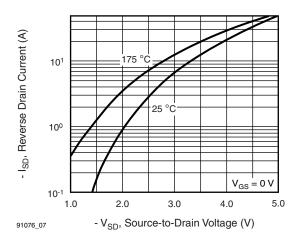


Fig. 7 - Typical Source-Drain Diode Forward Voltage

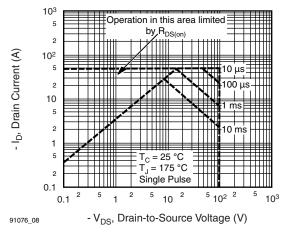


Fig. 8 - Maximum Safe Operating Area

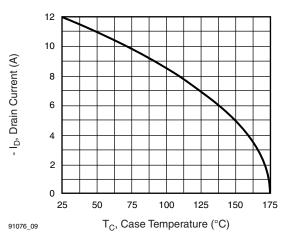


Fig. 9 - Maximum Drain Current vs. Case Temperature

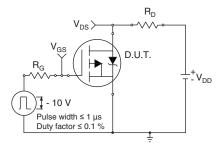


Fig. 10 - Switching Time Test Circuit

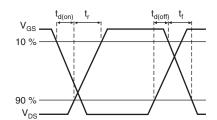


Fig. 11 - Switching Time Waveforms

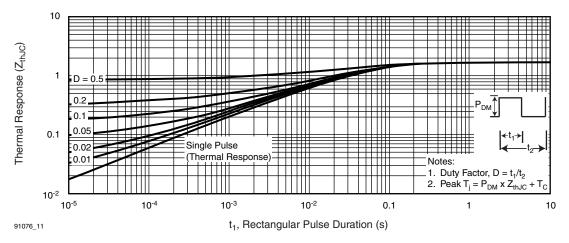


Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





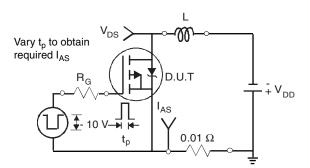


Fig. 13 - Unclamped Inductive Test Circuit

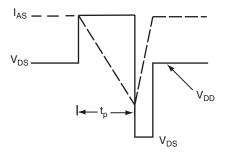


Fig. 14 - Unclamped Inductive Waveforms

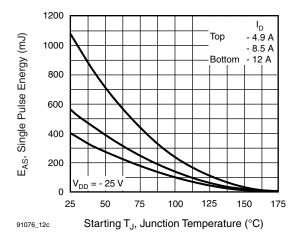


Fig. 15 - Maximum Avalanche Energy vs. Drain Current

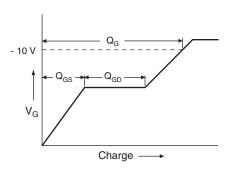


Fig. 16 - Basic Gate Charge Waveform

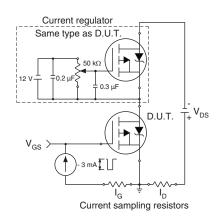
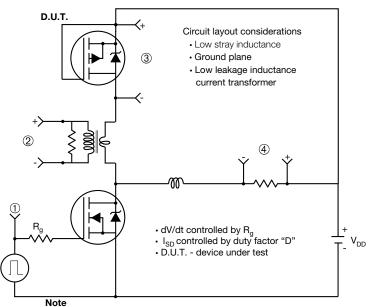


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

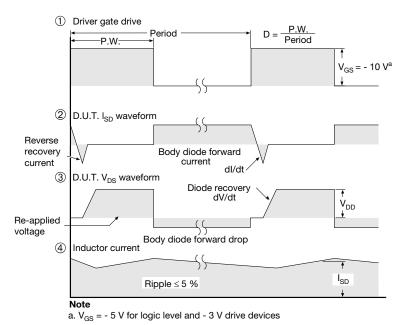


Fig. 18 - For P-Channel

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